_	~

Notice of References Cited

Application/Control No. 10/678,061	Applicant(s)/P Reexamination IMAI ET AL.	
Examiner	Art Unit	
Chris C. Chu	2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,744,090 B2	06-2004	Kim, Si-Bum	257/301
	В	US-6,680,514 B1	01-2004	Geffken et al.	257/368
	С	US-6,767,769 B2	07-2004	Hawley et al.	438/131
	D	US-6,346,741 B1	02-2002	Van Buskirk et al.	257/664
	E	US-5,554,866 A	09-1996	Nishioka et al.	257/295
	F	US-6,693,356 B2	02-2004	Jiang et al.	257/767
	G	US-6,656,830 B1	12-2003	Subramanian et al.	438/618
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 07030111 A	01-1995	Japan ·	NAGASU et al.	H01L 29/78
	0					
	Ρ					
	σ					
	R				0	
	ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	٧				
	w				
	×				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.